

**Search Notes**

Application/Control No.

10/759,076

Examiner

Steven Loke

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	300, 296, 288, 532	8/20/2005	SL
327	530	8/20/2005	SL
above	updated	3/28/2006	sl

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR